

**Notice of References Cited**

Application/Control No.

10/533,675

Applicant(s)/Patent Under  
Reexamination  
CHIBA, TATSURO

Examiner

Roberta Prendergast

Art Unit

2628

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,357,660	11-1982	Hepp, Vincent R.	702/10
*	B	US-6,915,310	07-2005	Gutierrez et al.	707/104.1
*	C	US-5,067,098	11-1991	Moellering et al.	345/426
*	D	US-5,357,484	10-1994	Bates et al.	367/118
*	E	US-5,452,406	09-1995	Butler et al.	345/426
*	F	US-5,552,787	09-1996	Schuler et al.	342/25A
*	G	US-5,604,820	02-1997	Ono, Shuji	382/190
*	H	US-5,631,981	05-1997	Rao, Arun	382/278
*	I	US-5,671,136	09-1997	Willhoit, Jr., Louis E.	702/18
*	J	US-5,825,188	10-1998	Montgomery et al.	324/357
*	K	US-6,073,079	06-2000	Thomas, Jimmy R.	702/9
*	L	US-6,456,288	09-2002	Brockway et al.	345/428
*	M	US-6,539,126	03-2003	Socolinsky et al.	382/274

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Shinohara, et al., "Color image analysis in a vector field ", Canadian Conference on Electrical and Computer Engineering, 14-17 Sept. 1993, pages 23-26.
	V	Kikukawa ET AL., "Solid Texturing o Riyo Shita 3-Jigen Nin'I Gamenjo ni Okeru Sensekibun Tatamikomiho", The Journal of the Institute of Image Electronics Engineers of Japan, 25 July 2000 (25.07.00), Vol. 29, No. 4, translation and original document, pages 1-3 and 283-291.
	W	Cabral, et al., "Imaging Vector Fields Using Line Integral Convolution", Proceedings of the 20th Annual Conference on Computer Graphics and interactive Techniques, SIGGRAPH '93, ACM, New York, NY, pages 263-270.
	X	Helman, J.L.; Hesselink, L.; "Visualizing vector field topology in fluid flows", IEEE Computer Graphics and Applications, Volume 11, Issue 3, May 1991, pages 36-46.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,735,557	05-2004	Castellar et al.	703/5
*	B	US-6,778,698	08-2004	Prakash et al.	382/164
*	C	US-6,985,606	01-2006	Wilkinson, Murray Justin	382/109
*	D	US-6,989,841	01-2006	Docherty, Paul	345/629
*	F	US-7,164,883	01-2007	Rappaport et al.	455/3.01
*	F	US-2003/0026762	02-2003	Malmros et al.	424/9.6
*	G	US-7,151,545	12-2006	Spicer, Sean	345/582
*	H	US-2003/0234781	12-2003	Laidlaw et al.	345/419
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Hotz, I., "Isometric embedding by surface reconstruction from distances", Proceedings of the Conference on Visualization '02, October 27 - November 01, 2002, VISUALIZATION, IEEE Computer Society, Washington, DC, pages 251-258.
	V	Interrante, V.; Grosch, C.; "Visualizing 3D flow", IEEE Computer Graphics and Applications, Volume 18, Issue 4, July-Aug. 1998, pages 49-53.
	W	Han-Wei Shen; Kao, D.L., "A new line integral convolution algorithm for visualizing time-varying flow fields", Transactions on Visualization and Computer Graphics, Volume: 4, Issue: 2, Apr-Jun 1998, page(s): 98-108.
	X	Han-Wei Shen; Johnson, C.R.; Kwan-Liu Ma; "Visualizing vector fields using line integral convolution and dye advection", Proceedings 1996 Symposium on Volume Visualization, 28-29 Oct. 1996, pages 63-70, 102.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.